Notice of References Cited 10/091,792 Examiner Tim Phan Reexamination HUBER ET AL. Page 1 of 1

Application/Control No.

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-6,311,390	11-2001	Abe et al.	29/612
	В	US-6,124,769	09-2000	Igarashi et al.	333/172
	С	US-		·	
	D	US-			
	E	US-			
	F	US-			·
	G	US-			
	Н	US-			
	1	US-			
	J	US-			
	К	US-			
	L	US-			
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification	
*	N	WO 99/53505	10-1999	WIPO	Raychem Corporation	H01C 7/13	
*	0	JP 06-283301	10-1994	Japan	Misubishi Materials Corp	H01C 7/00	
	Р						
	Q						
	R					,	
	S						
	Т						

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	w	
	х	•

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

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